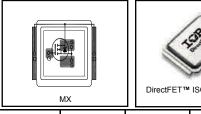


HEXFET® Power MOSFET plus Schottky Diode@

Typical values (unless otherwise specified)

- RoHs Compliant Containing No Lead and Bromide ②
- Integrated Monolithic Schottky Diode
- Low Profile (<0.7 mm)
- Dual Sided Cooling Compatible ①
- Low Package Inductance
- Optimized for High Frequency Switching
- Ideal for CPU Core DC-DC Converters
- Optimized for Sync. FET socket of Sync. Buck Converter
- Low Conduction and Switching Losses
- Compatible with existing Surface Mount Techniques ①
- 100% Rg tested
- Footprint compatible to DirectFET

 V_{DSS} V_{GS} R_{DS(on)} R_{DS(on)} 25V min 0.9mΩ @ 10V 1.4mΩ @ 4.5V ±16V max Q_{oss} $Q_{g tot}$ Q_{gs2} Q_{rr} Q_{gd} $V_{gs(th)}$ 31nC 3.0nC 1.6V 10nC 58nC 33nC





Applicable DirectFET[™] Outline and Substrate Outline (see p.7,8 for details) ①

							<u> </u>	
SQ	SX	ST	MQ	MX	MT	MP		

Description

The IRF6894MPbF combines the latest HEXFET® Power MOSFET Silicon technology with the advanced DirectFET™ packaging to achieve the lowest on-state resistance in a package that has the footprint of a SO-8 and only 0.7 mm profile. The DirectFET™ package is compatible with existing layout geometries used in power applications, PCB assembly equipment and vapor phase, infra-red or convection soldering techniques. Application note AN-1035 is followed regarding the manufacturing methods and processes. The DirectFET[™] package allows dual sided cooling to maximize thermal transfer in power systems, improving previous best thermal resistance by 80%.

The IRF6894MPbF balances industry leading on-state resistance while minimizing gate charge along with low gate resistance to reduce both conduction and switching losses. This part contains an integrated Schottky diode to reduce the Qrr of the body drain diode further reducing the losses in a Synchronous Buck circuit. The reduced losses make this product ideal for high frequency/high efficiency DC-DC converters that power high current loads such as the latest generation of microprocessors. The IRF6894MPbF has been optimized for parameters that are critical in synchronous buck converter's Sync FET sockets.

Book nort number	Bookege Type	Standard P	ack	Orderable Part Number	
Base part number	Package Type	Form	Quantity	Orderable Part Number	
IRF6894MTRPbF	DirectFET [®] Medium Can	Tape and Reel	4800	IRF6894MTRPbF	

Absolute Maximum Ratings

	Parameter	Max.	Units
V_{DS}	Drain-to-Source Voltage	25	\/
V_{GS}	Gate-to-Source Voltage	±16	V
$I_D @ T_A = 25^{\circ}C$	Continuous Drain Current, V _{GS} @ 10V (Silicon Limited) @	37	
$I_D @ T_A = 70^{\circ}C$	Continuous Drain Current, V _{GS} @ 10V (Silicon Limited) @	29	
$I_D @ T_C = 25^{\circ}C$	Continuous Drain Current, V _{GS} @ 10V (Silicon Limited) ^③	163	Α
I _{DM}	Pulsed Drain Current®	296	
E _{AS}	Single Pulse Avalanche Energy ®	540	mJ
I _{AR}	Avalanche Current ®	30	Α

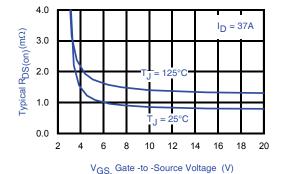


Fig 1. Typical On-Resistance vs. Gate Voltage Notes

- ① Click on this section to link to the appropriate technical paper.
- ② Click on this section to link to the DirectFET[™] Website.
- 3 Surface mounted on 1 in. square Cu board, steady state.

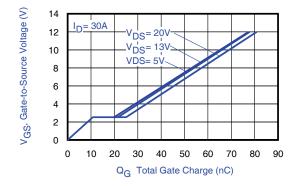


Fig 2. Typical Total Gate Charge vs. Gate-to-Source Voltage

- TC measured with thermocouple mounted to top (Drain) of part.
- © Repetitive rating; pulse width limited by max. junction temperature.
- © Starting $T_J = 25^{\circ}C$, L = 1.2 mH, $R_G = 50\Omega$, $I_{AS} = 30 \text{A}$.



Static @ T_J = 25°C (unless otherwise specified)

	Parameter	Min.	Тур.	Max.	Units	Conditions
BV_{DSS}	Drain-to-Source Breakdown Voltage	25			V	$V_{GS} = 0V, I_{D} = 1.0mA$
$\Delta BV_{DSS}/\Delta T_{J}$	Breakdown Voltage Temp. Coefficient		0.02		V/°C	I _D = 10mA (25°C-125°C)
R _{DS(on)}	Static Drain-to-Source On-Resistance		0.9	1.3	0	V _{GS} = 10V, I _D = 37A ⑦
			1.4	1.8	mΩ	V _{GS} = 4.5V, I _D = 30A ⑦
$V_{GS(th)}$	Gate Threshold Voltage	1.1	1.6	2.1	V	$V_{DS} = V_{GS}$, $I_D = 100\mu A$
$\Delta V_{GS(th)}/\Delta T_J$	Gate Threshold Voltage Temp. Coefficient		-3.8		mV/°C	$V_{DS} = V_{GS}$, $I_D = 10$ mA
I _{DSS}	Drain-to-Source Leakage Current			500	μA	V _{DS} = 20 V, V _{GS} = 0V
	Gate-to-Source Forward Leakage			100	~ Λ	V _{GS} = 16V
I _{GSS}	Gate-to-Source Reverse Leakage			-100	nA	V _{GS} = -16V
gfs	Forward Transconductance	193			S	$V_{DS} = 13V, I_{D} = 30A$
Q_g	Total Gate Charge		31	47		
Q_{gs1}	Pre- Vth Gate-to-Source Charge		8.1			$V_{DS} = 13V$
Q_{gs2}	Post– Vth Gate-to-Source Charge		3.0		nC	$V_{GS} = 4.5V$
Q_{gd}	Gate-to-Drain Charge		10		IIC	I _D = 30A
Q_{godr}	Gate Charge Overdrive		10			See Fig 15
Q _{sw}	Switch Charge (Q _{gs2 +} Q _{gd)}		13			
Q_{oss}	Output Charge		33		nC	$V_{DS} = 16V, V_{GS} = 0V$
R_G	Gate Resistance		0.2		Ω	
$t_{d(on)}$	Turn-On Delay Time		17			V _{DD} = 13V, V _{GS} = 4.5V⊘
t _r	Rise Time		47			$I_{D} = 30A$
$t_{d(off)}$	Turn-Off Delay Time		23		ns	$R_G = 1.8\Omega$
t_f	Fall Time		13			See Fig 17
C _{iss}	Input Capacitance		4232			V _{GS} = 0V
C _{oss}	Output Capacitance		1260		pF	V _{DS} = 13V
C _{rss}	Reverse Transfer Capacitance		255			f = 1.0MHz

Diode Characteristics

	Parameter	Min.	Тур.	Max.	Units	Conditions
I _S	Continuous Source Current (Body Diode)			37		MOSFET symbol showing the
I _{SM}	Pulsed Source Current (Body Diode) ⑤			296		integral reverse p-n junction diode.
V_{SD}	Diode Forward Voltage			0.75	V	$T_J = 25^{\circ}C, I_S = 30A, V_{GS} = 0V \oslash$
t _{rr}	Reverse Recovery Time		28	42	ns	$T_J = 25^{\circ}C, I_F = 30A$
Q_{rr}	Reverse Recovery Charge		58	87	nC	di/dt = 320A/µs ⑦

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S Repetitive rating; pulse width limited by max. junction temperature.
 Pulse width ≤ 400µs; duty cycle ≤ 2%.



Absolute Maximum Ratings

Symbol	Parameter	Max.	Units
$P_D @ T_A = 25^{\circ}C$	Power Dissipation ③④	2.8	
$P_D @ T_A = 70^{\circ}C$	Power Dissipation ③④	1.8	W
$P_D @ T_C = 25^{\circ}C$	Power Dissipation 4	54	
T_P	Peak Soldering Temperature	270	
T_J	Operating Junction and	-40 to + 150	°C
T _{STG}	Storage Temperature Range		°C

Thermal Resistance

Symbol	Parameter	Тур.	Max.	Units
$R_{ hetaJA}$	Junction-to-Ambient ③		45	
$R_{ heta JA}$	Junction-to-Ambient ®	12.5		
$R_{ heta JA}$	Junction-to-Ambient ®	20		°C/W
$R_{ heta JC}$	Junction-to-Can 4 ®	tion-to-Can 🖲 🗓 — 2.3		
R _{0JA-PCB}	Junction-to-PCB Mounted	1.0		
	Linear Derating Factor ③	0.0	022	W/°C

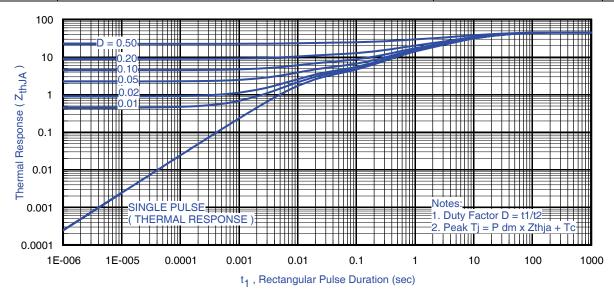


Fig 3. Maximum Effective Transient Thermal Impedance, Junction-to-Ambient®

Notes:

- ③ Surface mounted on 1 in. square Cu board, steady state.
- ④ T_C measured with thermocouple incontact with top (Drain) of part.
- ® Used double sided cooling, mounting pad with large heatsink.
- Mounted on minimum footprint full size board with metalized back and with small clip heatsink.
- 1 R_{θ} is measured at T_J of approximately 90°C.



③ Surface mounted on 1 in. square Cu board (still air).



Mounted to a PCB with small clip heatsink (still air)



 Mounted on minimum footprint full size board with metalized back and with small clip heatsink (still air)



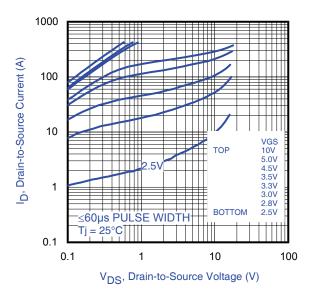


Fig 4. Typical Output Characteristics

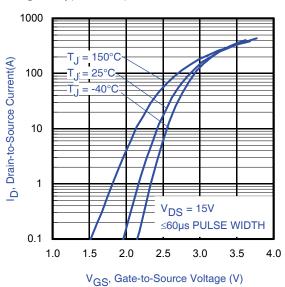


Fig 6. Typical Transfer Characteristics

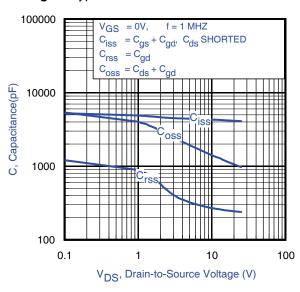


Fig 8. Typical Capacitance vs. Drain-to-Source Voltage

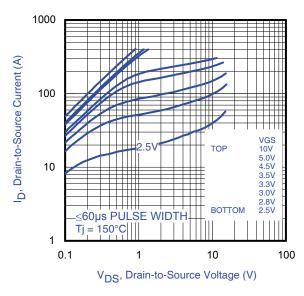


Fig 5. Typical Output Characteristics

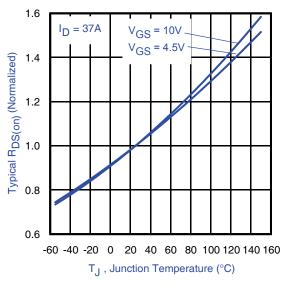


Fig 7. Normalized On-Resistance vs. Temperature

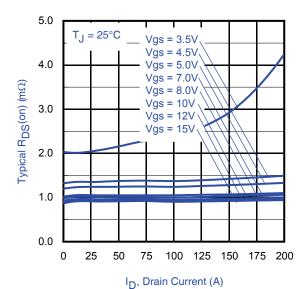


Fig 9. Typical On-Resistance vs. Drain Current and Gate Voltage



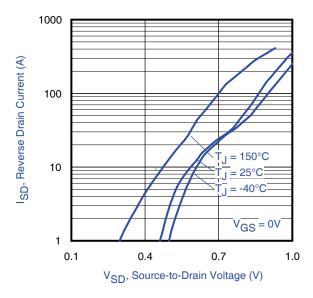
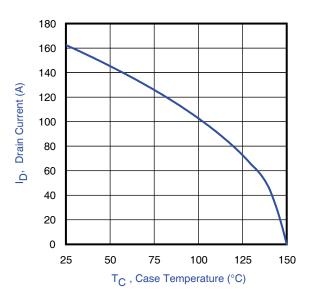


Fig 10. Typical Source-Drain Diode Forward Voltage



10000 OPERATION IN THIS AREA IMITED BY R.DS(on) 1000 ID, Drain-to-Source Current (A) 100 10msec 10 25°C 0.1 Tj = 150°C Single Pulse 0.01 0.0 0.1 1.0 10.0 100.0 V_{DS} , Drain-toSource Voltage (V)

Fig 11. Maximum Safe Operating Area

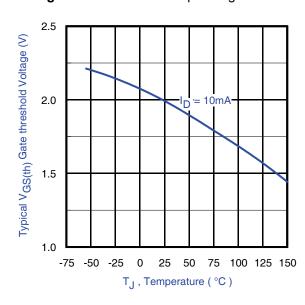


Fig 12. Maximum Drain Current vs. Case Temperature



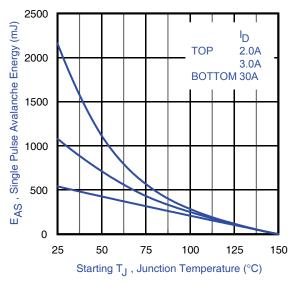


Fig 14. Maximum Avalanche Energy vs. Drain Current

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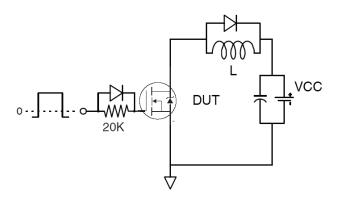


Fig 15a. Gate Charge Test Circuit

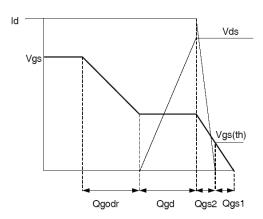


Fig 15b. Gate Charge Waveform

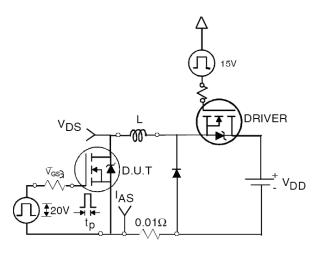


Fig 16a. Unclamped Inductive Test Circuit

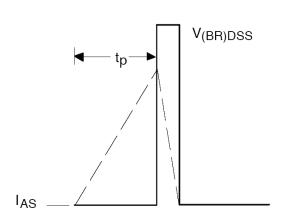


Fig 16b. Unclamped Inductive Waveforms

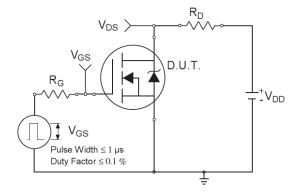


Fig 17a. Switching Time Test Circuit

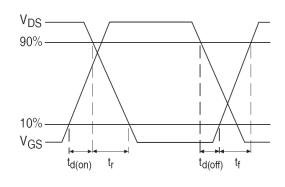


Fig 17b. Switching Time Waveforms



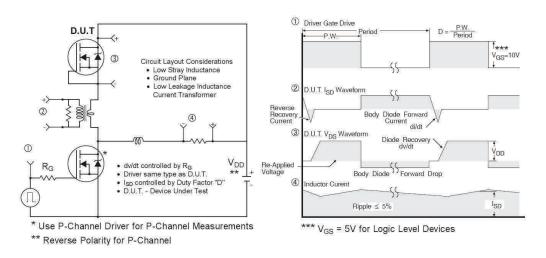
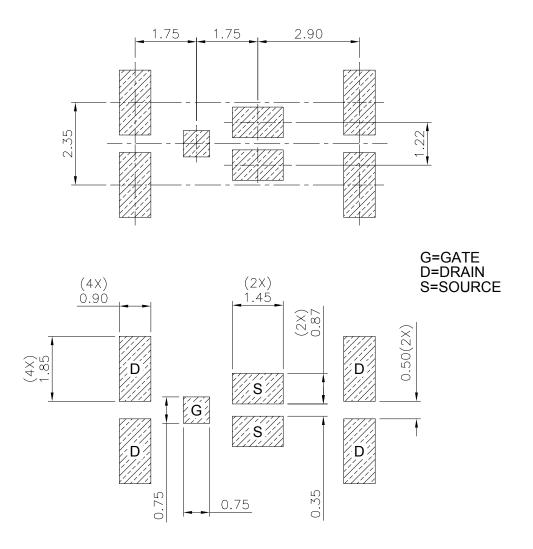


Fig 18. Diode Reverse Recovery Test Circuit for HEXFET® Power MOSFETs

DirectFET[™] Board Footprint, MX Outline

(Medium Size Can, X-Designation).
Please see DirectFET[™] application note <u>AN-1035</u> for all details regarding the assembly of DirectFET[™]. This includes all recommendations for stencil and substrate designs.



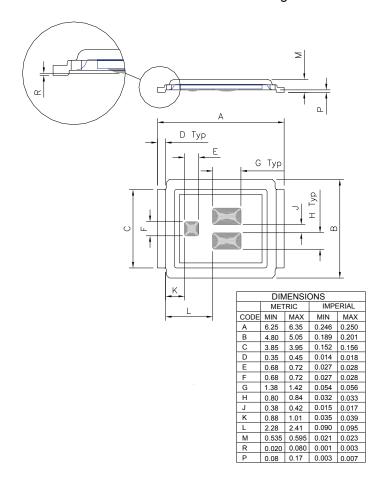
Note: For the most current drawing please refer to website at http://www.irf.com/package/

2016-10-13

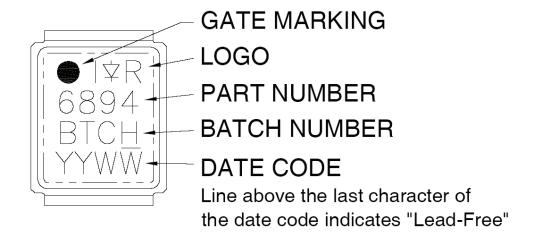


DirectFET[™] Outline Dimension, MX Outline (Medium Size Can, X-Designation).

Please see DirectFET[™] application note <u>AN-1035</u> for all details regarding the assembly of DirectFET[™]. This includes all recommendations for stencil and substrate designs.



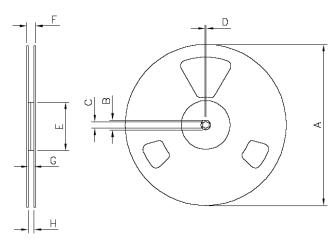
DirectFET[™] Part Marking



Note: For the most current drawing please refer to website at http://www.irf.com/package/



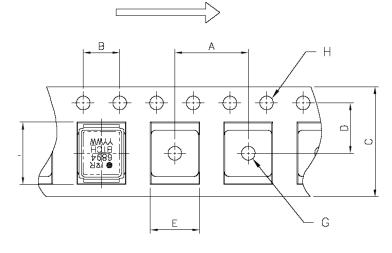
DirectFET[™] Tape & Reel Dimension (Showing component orientation).



NOTE: Controlling dimensions in mm Std reel quantity is 4800 parts. (ordered as IRF6894MTRPBF). For 1000 parts on 7° reel, order IRF6894MTR1PBF

	REEL DIMENSIONS								
STANDARD OPTION (QTY 4800)					TR	OPTION	(QTY 10	00)	
	ME	TRIC	IMP	ERIAL	METRIC		IMPERIAL		
CODE	MIN	MAX	MIN	MAX	MIN	MAX	MIN	MAX	
Α	330.0	N.C	12.992	N.C	177.77	N.C	6.9	N.C	
В	20.2	N.C	0.795	N.C	19.06	N.C	0.75	N.C	
С	12.8	13.2	0.504	0.520	13.5	12.8	0.53	0.50	
D	1.5	N.C	0.059	N.C	1.5	N.C	0.059	N.C	
E	100.0	N.C	3.937	N.C	58.72	N.C	2.31	N.C	
F	N.C	18.4	N.C	0.724	N.C	13.50	N.C	0.53	
G	12.4	14.4	0.488	0.567	11.9	12.01	0.47	N.C	
Н	11.9	15.4	0.469	0.606	11.9	12.01	0.47	N.C	

LOADED TAPE FEED DIRECTION



NOTE: CONTROLLING DIMENSIONS IN MM

DIMENSIONS							
METRIC		IMPERIAL					
MIN MAX		MIN	MAX				
7.90	8.10	0.311	0.319				
3.90	4.10	0.154	0.161				
11.90	12.30	0.469	0.484				
5.45	5.55	0.215	0.219				
5.10	5.30	0.201	0.209				
6.50	6.70	0.256	0.264				
1.50	N.C	0.059	N.C				
1.50	1.60	0.059	0.063				
	MET MIN 7.90 3.90 11.90 5.45 5.10 6.50 1.50	METRIC MIN MAX 7.90 8.10 3.90 4.10 11.90 12.30 5.45 5.55 5.10 5.30 6.50 6.70 1.50 N.C	METRIC IMPE MIN MAX MIN 7.90 8.10 0.311 3.90 4.10 0.154 11.90 12.30 0.469 5.45 5.55 0.215 5.10 5.30 0.201 6.50 6.70 0.256 1.50 N.C 0.059				

Note: For the most current drawing please refer to website at http://www.irf.com/package/



Qualification Information

Qualification Level	Industrial [†]			
Moisture Sensitivity Level	DirectFET [™] Medium Can	MSL1 (per JEDEC J-STD-020D ^{†)}		
RoHS Compliant		Yes		

† Applicable version of JEDEC standard at the time of product release.

Revision History

Date	Comment
10/13/2016	 Changed datasheet with "Infineon" logo –all pages. Changed Rth from "60°C/W" to "45°C/W" –page 3 Changed ID @ TA 25C/70C from "32A/25A" to "37A/29A" –page 1 & 2. Changed Fig.1 to Fig.15 –page 1 to 9. Added disclaimer on last page.

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